

Search Notes**Application/Control No.**

10/696,431

Examiner

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Applicant(s)/Patent under Reexamination

HAN ET AL.

Art Unit

3729

SEARCHED

Class	Subclass	Date	Examiner
29	603.07 603.11 603.13- 603.16	11/15/2006	PK
	603.18		
360	235.2		
	234.7		
	319 320	↓	

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Search EAST/PGPub	11/15/2006	pk
Updated Text Search EAST/PGPub	11/20/2006	PK
Updated Text Search EAST/PGPub	4/17/2007	PK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner